

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ROEHR ET AL.	
		Examiner Hiep T. Nguyen	Art Unit 2187	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0123033	06-2004	Rudelic, John C.	711/118
	B	US-2004/0080988	04-2004	Harari et al.	365/200
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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